

FORM 1449 (S&J Version)

INFORMATION DISCLOSURE STATEMENT
BY APPLICANT

Docket No.: 12492.0004-D1

Applicant: GROGER et al.

Application No.: 10/073,041

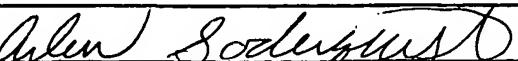
Filing Date February 12, 2002

Examiner: Soderquist

Group Art Unit: 1743

U.S. PATENT DOCUMENTS						
Examiner's Initials*	Document No.	Date MM/YYYY	Inventor	Class	Subclass	Filing Date If Appropriate
						
Examiner's Initials*						
						
OTHER DOCUMENTS						
Examiner's Initials*	Include author, title of article, title of item (book, journal, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.					
AS	Weiss et al., "Thin Film Monitoring Using Surface Plasmon Resonance Waveguide Sensors," pp. 1-20, Photonics Research Laboratory, University of Florida, Gainesville, FL					
AS	Kelsch, James A., "Computer Block Diagram," Computer BMP, Arcova, Gainesville, FL					
AS	* Groger et al., "Thin Film Sensors to Evaluate Chemical and Biological Threats to Army Structures", February 1992, pp. 1-41, American Research Corporation of Virginia, Radford, VA.					
AS	Churchill et al., "Self-assembled Thin Film Sensors for Aquaculture Process Control", SBIR Phase I Final Report, Dec. 30, 1992, pp. 1-55, American Research Corporation of Virginia, Radford, VA.					
AS	Haruvy et al., "Sol-Gel Preparation of Optically Clear Supported Thin-Film Glasses Embodying Laser Dyes", 1992, Chapter 28, pp. 405-424, Supramolecular Architecture, USA.					
AS	Levy, David, "Sol-gel glasses for optics and electro-optics", Journal of Non-Crystalline Solids, Section 10, 147-148 (1992) pp. 508-517, North Holland.					
AS	Reisfeld et al., "Optical Properties of Colorants or Luminescent Species in Sol-Gel Glasses", Structure and Bonding 77, Springer-Verlag, 1992, pp. 239-247, Berlin, Heidelberg.					
AS	Zusman et al., "Doped Sol-Gel Glasses as Chemical Sensors", Journal of Non-Crystalline Solids, Vol. 122, 1990, pp. 107-109, North Holland.					
AS	Jahns et al., "Integrated planar optical imaging system with high interconnection density", Optical Letters, Vol. 18, No. 19, Oct. 1, 1993, pp. 1594-1596.					
AS	Tanguay, Armand R., Jr., "Integrated Optical Information Processing" Research Report 1988, USC Optical Materials and Devices Laboratory, pp. 1-14, Los Angeles, CA, 63-71.					
AS	Feddersen et al., "Digital parallel acquisition in frequency domain fluorimetry", Rev. Sci. Instrum., Vol. 60, No. 9, September 1989, pp. 2929-2936.					
	Haruvy et al., "Supported sol-gel thin-film glasses embodying laser dyes II: Three-layered waveguide assemblies", SPIE, Vol. 1590, Submolecular Glass Chemistry and Physics, 1991, pp. 59-70.					
AS	Chen et al., "1-to-12 surface normal three-dimensional optical interconnects", Applied Physics Letters, Vol. 63, No. 14, October 1993, pp. 17-19.					

* Copy not presently available.

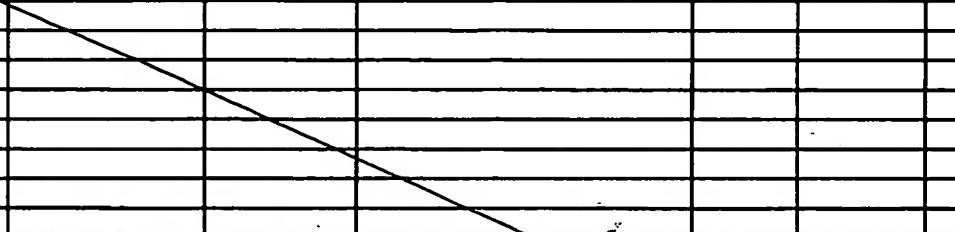
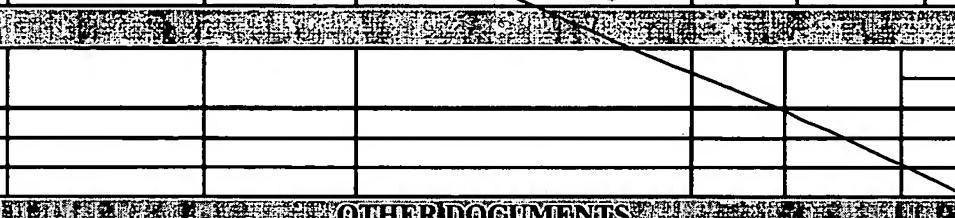
Examiner's Signature		Date Considered	12/29/04
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*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.



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Examiner's Signature	<i>Alan Sodergren</i>	Date Considered	12/29/04
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